

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination		
		10/774,796	HSIEH, JIANG	
Examiner		Art Unit		
David V. Bruce		2882		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
378	4,8,15		
	901		
382	131		
Interference search attached			